Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/539,818	HUBSCHEN ET AL.	
Examiner	Art Unit	
John E. Chapman	2856	

SEARCHED				
Class	Subclass	Date	Examiner	
73	643	12/21/2007	JC	

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Class	Subclass	Date	Examiner		
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